

PTO/SB/08A (10-01) Approved for use through 10/31/2002.OMB 0651-0031

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Sub	stitute for form 1449A/PTO		Complete if Known		
		•	Application Number	09/943,190	
11	VEORMATION	N DISCLOSURE	Filing Date	August 29, 2001	
S	TATEMENT I	BY APPLICANT	First Named Inventor	Kristy A. Campbell	
			Art Unit	2818 2825	
	(use as many sh	eets as necessary)	Examiner Name	Not Yet Assigned Rocched	
Sheet	1	2	Attorney Docket Number	M4065.0698/P698	

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Examiner	Cite No.1	Cite	Cite	Cite	Cite	Cite	Cite	Cite	Document Number	Publication Date	Name of Patentee or Applicant	Peges, Columns, Lines, Where Relevant
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Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ³ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Cotumns, Lines, Where Relevant Passages or Relevant Figures Appear	T°		
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Examiner Signature Lewis N	louh	l'an'	Date Considered	11/19/2003

^{*}EXAMINER: Initial if reference considered, whether or not cliation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant

¹ Applicant's unique citation designation number (optional). ² See attached Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. ⁶ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.



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٠				Art Unit	2818-2128	
	(use as man	y sheets as	necessary)	Examiner Name	Not Yet Assigned Rucch	
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